

AUTOMOTIVE GRADE

AUIRLR2905 AUIRLU2905

Features

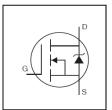
- Advanced Planar Technology
- Logic Level Gate Drive
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

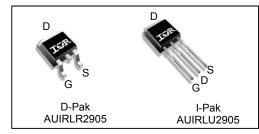
Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



HEXFET® Power MOSFET



V _{DSS}	55V
R _{DS(on)} max.	27 mΩ
I _D	42A



G	D	S
Gate	Drain	Source

Base nort number	Standard Pack			Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRLU2905	I-Pak	Tube	75	AUIRLU2905
ALUDI DOOG	D. Dak	Tube	75	AUIRLR2905
AUIRLR2905 D-Pak		Tape and Reel Left	3000	AUIRLR2905TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	42	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	30	Α
I _{DM}	Pulsed Drain Current ①	160	
P _D @T _C = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
V_{GS}	V _{GS} Gate-to-Source Voltage		V
E _{AS}			1
E _{AS (tested)}	Single Pulse Avalanche Energy (tested Value) ®	200	— mJ
I _{AR}	Avalanche Current ①	25	А
E _{AR}	Repetitive Avalanche Energy ①	11	mJ
dv/dt	Peak Diode Recovery®	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.4	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ©		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.070		V/°C	Reference to 25°C, I _D = 1mA
				0.027		V _{GS} = 10V, I _D = 25A ④
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.030	Ω	V _{GS} = 5.0V, I _D = 25A ④
				0.040		V _{GS} = 4.0V, I _D = 21A ④
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	21			S	$V_{DS} = 25V, I_{D} = 25A$
ı	Drain-to-Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
ı	Gate-to-Source Forward Leakage			100	n ^	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = - 16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge			48		I _D = 25A
Q_{gs}	Gate-to-Source Charge			8.6	nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain Charge			25		V _{GS} = 5.0V ④
$t_{d(on)}$	Turn-On Delay Time		11			$V_{DD} = 28V$
t _r	Rise Time		84		no	I _D = 25A
$t_{d(off)}$	Turn-Off Delay Time		26		ns	$R_G = 3.4\Omega, V_{GS} = 5.0V$
t _f	Fall Time		15			$R_D = 1.1\Omega \oplus$
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance		7.5			from package and center of die contact
C _{iss}	Input Capacitance		1700			$V_{GS} = 0V$
Coss	Output Capacitance		400		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		150			f = 1.0MHz, See Fig. 5

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			42		MOSFET symbol
	(Body Diode) Pulsed Source Current			160	4 A	showing the integral reverse
I _{SM}	(Body Diode) ①			100		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 25A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		80	120	ns	$T_J = 25^{\circ}C$, $I_F = 25A$
Qrr	Reverse Recovery Charge		210	320	nC	di/dt = 100A/μs④
ton	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L _S +L _D)

Notes:

- $\, \mathbb{O} \,$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② $V_{DD} = 25V$, Starting $T_J = 25$ °C, $L = 470\mu H$, $R_G = 25\Omega$, $I_{AS} = 25A$ (See fig. 12)
- $\label{eq:loss_state} \mbox{\Im} \quad I_{SD} \leq 25A, \ di/dt \leq 270A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- ④ Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- © R_θ is measured at T_i approximately 90°C.



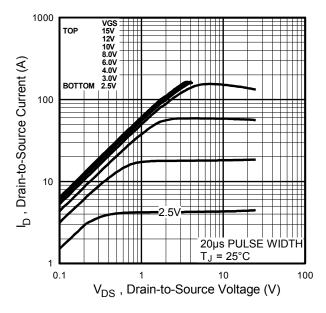


Fig. 1 Typical Output Characteristics

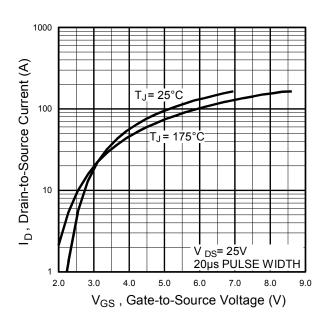


Fig. 3 Typical Transfer Characteristics

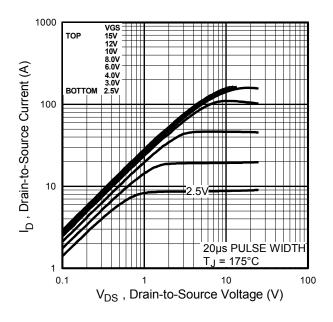


Fig. 2 Typical Output Characteristics

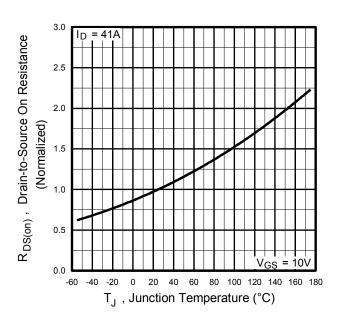


Fig. 4 Normalized On-Resistance Vs. Temperature



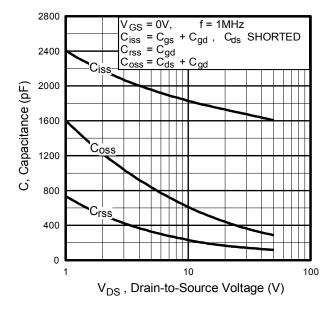


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

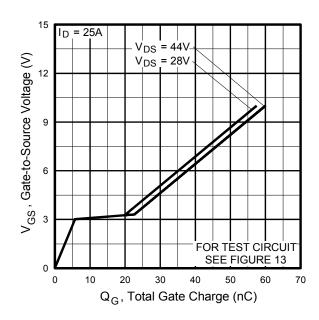


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

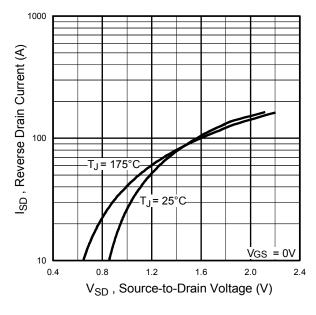


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

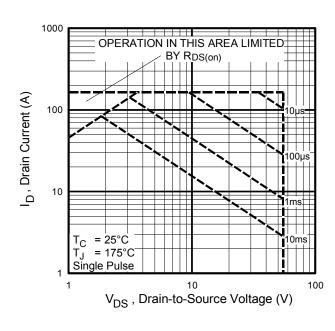


Fig 8. Maximum Safe Operating Area



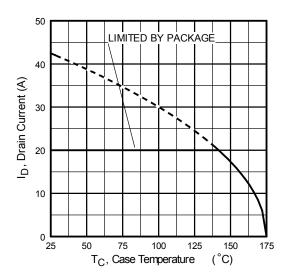


Fig 9. Maximum Drain Current Vs. Case Temperature

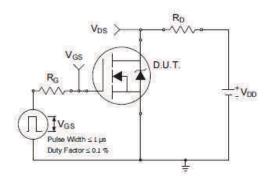


Fig 10a. Switching Time Test Circuit

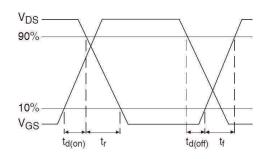


Fig 10b. Switching Time Waveforms

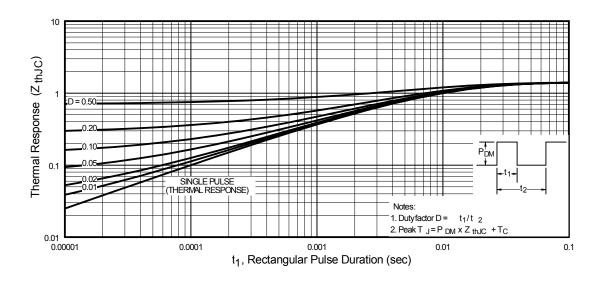


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



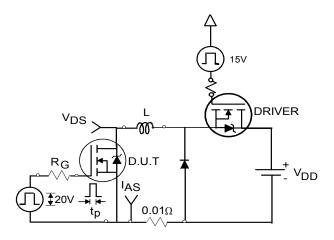


Fig 12a. Unclamped Inductive Test Circuit

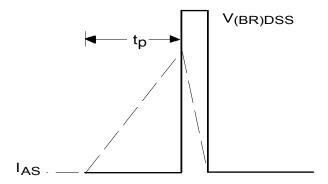


Fig 12b. Unclamped Inductive Waveforms

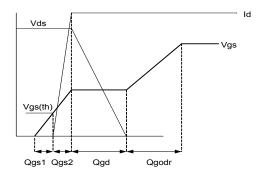


Fig 13a. Gate Charge Waveform

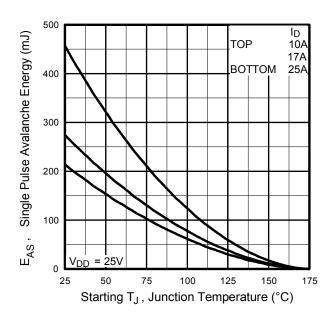


Fig 12c. Maximum Avalanche Energy vs. Drain Current

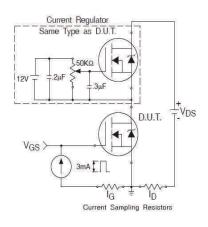


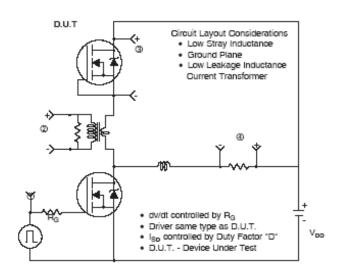
Fig 13b. Gate Charge Test Circuit

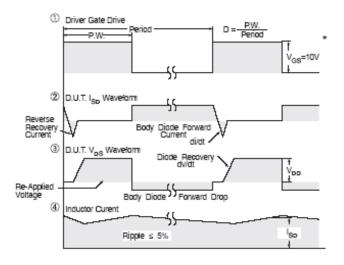
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6



Peak Diode Recovery dv/dt Test Circuit



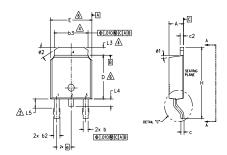


^{*} V_{GS} = 5V for Logic Level Devices

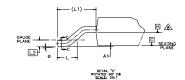
Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

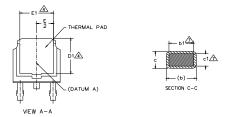


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- ⚠- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M		DIMEN	SIONS		Ŋ
B	MILLIM	MILLIMETERS INC		HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
с1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0,	10*	0,	10°	
ø1	0,	15*	0.	15*	
ø2	25*	35°	25*	35°	

LEAD ASSIGNMENTS

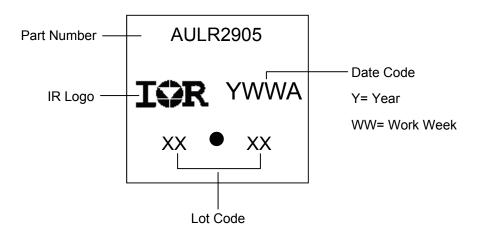
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4. COLLECTOR

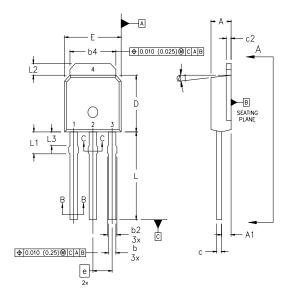
D-Pak (TO-252AA) Part Marking Information

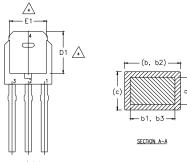


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

SYMBOL

Α1

ь1

b2

ь3

b4

c1

c2

D

D1

Ε

E1

L1

L2

L3

ø1

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

INCHES

.094

0.045

0.035

0.031

0.045

0.041

0.215

0.024

0.022

0.035

0.245

0.265

0.380

0.050

0.060

15*

MIN.

0.086

0.035

0.025

0.025

0.030

0.030

0.195

0.018

0.016

0.018

0.235

0.205

0.250

0.170

0.350

0.075

0.035

0.045

0.

0.090 BSC

NOTES

3, 4

LEAD DIMENSION UNCONTROLLED IN L3.

DIMENSION 61, 63 APPLY TO BASE METAL ONLY.

MAX

2.39

1 14

0.89

0.79

1.14

1.04

5.46

0.61

0.56

0.86

6.22

6.73

9.60

2.29

1.27

1.52

15°

OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

DIMENSIONS

CONTROLLING DIMENSION : INCHES.

MILLIMETERS

MIN.

2.18

0.89

0.64

0.64

0.76

0.76

5.00

0.46

0.41

.046

5.97

5.21

6.35

4.32 2.29

8.89

1.91

0.89

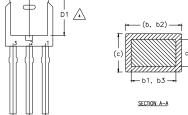
1.14

0.

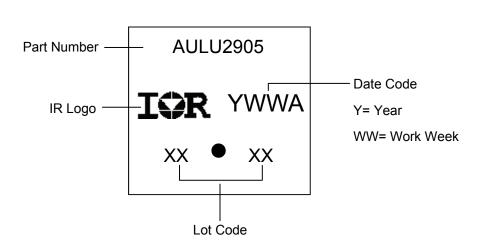
LEAD	ASSIGN	<u>MENTS</u>

н	FΥ	FF	Т

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN



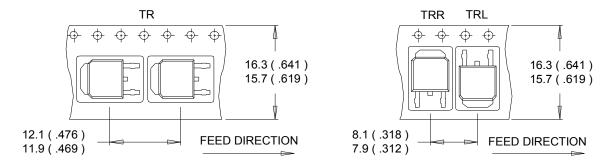
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

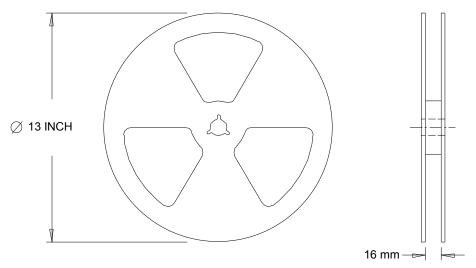


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive					
			(per AEC-Q101)				
			is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higher el.				
Moisture Sensitivity Level		D-Pak	MCI 1				
		I-Pak	MSL1				
			Class M4 (+/- 425V) [†]				
	Machine Model	AEC-Q101-002					
FOD	Llucasa Dadu Madal	Class H1B (+/- 1000V) †					
ESD	Human Body Model	AEC-Q101-001					
	Observed Davis a Madal	Class C5 (+/- 1125V) [†]					
Charged Device Model		AEC-Q101-005					
RoHS Co	S Compliant Yes		Yes				

[†] Highest passing voltage.

Revision History

Date	Comments
12/11/2015	 Updated datasheet with corporate template Corrected ordering table on page 1.
	Added package outline and part marking on page 9

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